

### . . eescale Semiconductor

Technical Data

Will be replaced by MRF9002NR2 in Q305. N suffix indicates 260°C reflow capable. The PFP-16 package has had lead-free terminations from its initial release.

### **RF Power Field Effect Transistor Array**

#### N-Channel Enhancement-Mode Lateral MOSFET

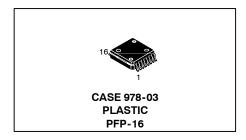
Designed for broadband commercial and industrial applications with frequencies to 1000 MHz. The high gain and broadband performance of this device make it ideal for large-signal, common-source amplifier applications in 26 volt base station equipment. The device is in a PFP-16 Power Flat Pack package which gives excellent thermal performances through a solderable backside contact.

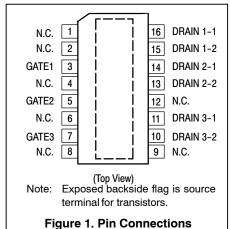
- Typical Performance at 960 MHz, 26 Volts
   Output Power 2 Watts Per Transistor
   Power Gain 18 dB
   Efficiency 50%
- · Designed for Maximum Gain and Insertion Phase Flatness
- Capable of Handling 10:1 VSWR, @ 26 Vdc, 960 MHz, 2 Watts CW Output Power
- Excellent Thermal Stability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- In Tape and Reel. R2 Suffix = 1,500 Units per 16 mm, 13 inch Reel.

#### Document Number: MRF9002R2 Rev. 6, 7/2005

# MRF9002R2

1000 MHz, 2 W, 26 V LATERAL N-CHANNEL BROADBAND RF POWER MOSFET





#### **Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	- 0.5, +65	Vdc
Gate-Source Voltage	V <sub>GS</sub>	- 0.5, +15	Vdc
Total Dissipation Per Transistor @ T <sub>C</sub> = 25°C	P <sub>D</sub>	4	W
Storage Temperature Range	T <sub>stg</sub>	- 65 to +150	°C
Operating Junction Temperature	TJ	150	°C

#### **Table 2. Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case, Single Transistor		12	°C/W

#### **Table 3. Moisture Sensitivity Level**

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD 22-A113, IPC/JEDEC J-STD-020	3	240	°C

NOTE - **CAUTION** - MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.





**Table 4. Electrical Characteristics** ( $T_C = 25^{\circ}C$  unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
On Characteristics					
Gate Threshold Voltage $(V_{DS} = 10 \text{ Vdc}, I_D = 20 \mu\text{Adc})$	V <sub>GS(th)</sub>	2.4	_	4	Vdc
Gate Quiescent Voltage (V <sub>DS</sub> = 26 Vdc, I <sub>D</sub> = 25 mAdc)	V <sub>GS(Q)</sub>	3	_	5	Vdc
Drain-Source On-Voltage $(V_{GS} = 10 \text{ Vdc}, I_D = 0.1 \text{ Adc})$	V <sub>DS(on)</sub>	_	0.3	_	Vdc
Functional Tests (Per Transistor in Freescale Test Fixture, 50 ohm s	unctional Tests (Per Transistor in Freescale Test Fixture, 50 ohm system)				
Common-Source Amplifier Power Gain @ P1dB (V <sub>DD</sub> = 26 Vdc, I <sub>DQ</sub> = 25 mA, f = 960.0 MHz)	G <sub>ps</sub>	15	18	_	dB
Drain Efficiency @ P1dB (V <sub>DD</sub> = 26 Vdc, I <sub>DQ</sub> = 25 mA, f = 960.0 MHz)	η	35	50	_	%
Input Return Loss @ P1dB (V <sub>DD</sub> = 26 Vdc, I <sub>DQ</sub> = 25 mA, f = 960.0 MHz)	IRL	_	- 15	- 9	dB
Power Output, 1 dB Compression Point (V <sub>DD</sub> = 26 Vdc, I <sub>DQ</sub> = 25 mA, f = 960.0 MHz)	P <sub>1dB</sub>	34	37	_	dBm
Output Mismatch Stress (V <sub>DD</sub> = 26 Vdc, P <sub>out</sub> = 2 W CW, I <sub>DQ</sub> = 25 mA, f = 960.0 MHz, VSWR = 10:1, All Phase Angles at Frequency of Tests)	Ψ	No Degradation In Output Power			



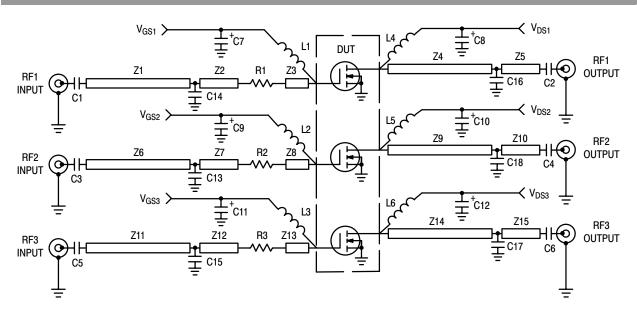
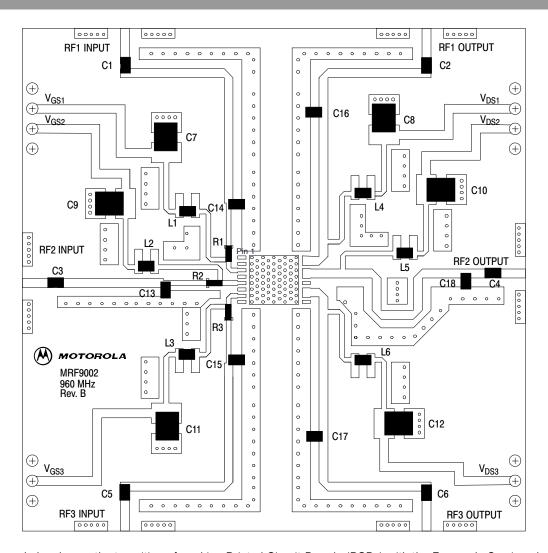


Figure 2. MRF9002R2 Broadband Test Circuit Schematic

Table 5. MRF9002R2 Broadband Test Circuit Component Designations and Values

Designators	Description
C1-C6	33 pF Chip Capacitors (0805)
C7-C12	1.0 μF, 35 V Tantalum Capacitors, Kemet
C13	8.2 pF Chip Capacitor (0805)
C14, C15	10 pF Chip Capacitors (0805)
C16, C17	2.7 pF Chip Capacitors (0805)
C18	3.3 pF Chip Capacitor (0805)
L1-L6	12 nH Chip Inductors (0805)
R1-R3	0 Ω Chip Resistors (0805)
Z1, Z11	1.16 x 28.5 mm Microstrip
Z2, Z7, Z12	0.65 x 5.6 mm Microstrip
Z3, Z8, Z13	0.65 x 2.6 mm Microstrip
Z4, Z14	1.16 x 19.5 mm Microstrip
Z5, Z15	1.16 x 17.5 mm Microstrip
Z6	1.16 x 12.9 mm Microstrip
Z9	1.16 x 27.2 mm Microstrip
Z10	1.16 x 4.3 mm Microstrip
PCB	Etched Circuit Board
Raw PCB Material	Rogers RO4350, 0.020", 2.5", x 2.5", $\varepsilon_r$ = 3.5
Bedstead	Copper Heatsink





Freescale has begun the transition of marking Printed Circuit Boards (PCBs) with the Freescale Semiconductor signature/logo. PCBs may have either Motorola or Freescale markings during the transition period. These changes will have no impact on form, fit or function of the current product.

Figure 3. MRF9002R2 Broadband Test Circuit Component Layout



#### TYPICAL CHARACTERISTICS

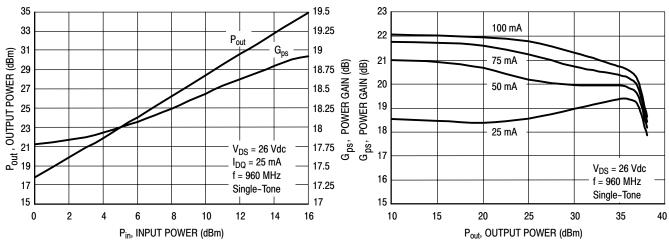


Figure 4. Output Power and Power Gain versus Input Power

Figure 5. Power Gain versus Output Power

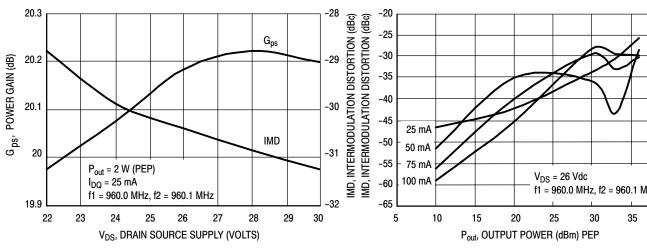


Figure 6. Power Gain and Intermodulation Distortion versus Supply Voltage

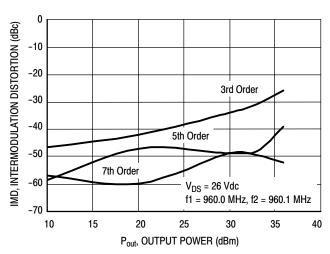
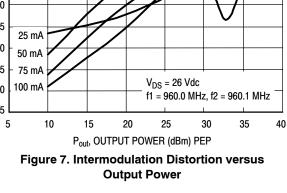


Figure 8. Intermodulation Distortion Products versus Output Power



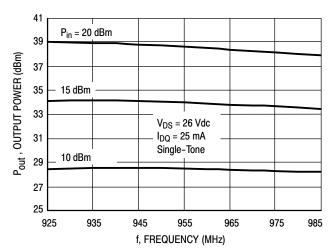


Figure 9. Output Power versus Frequency

MRF9002R2



#### **TYPICAL CHARACTERISTICS**

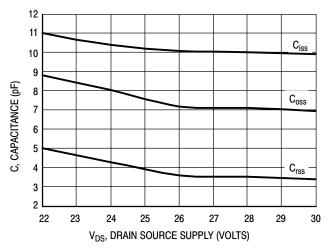
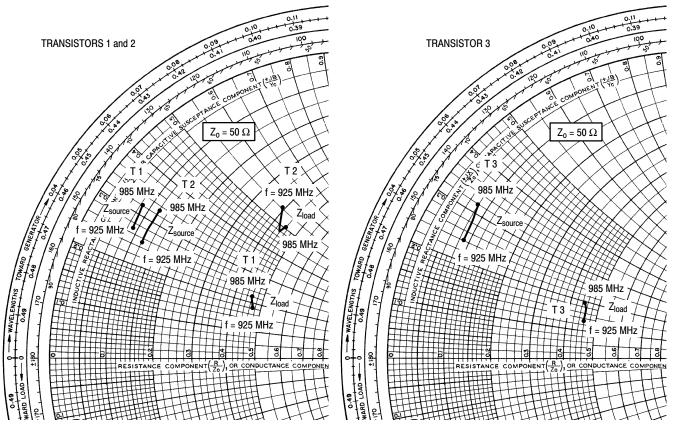


Figure 10. Capacitance versus Drain Source Voltage





 $V_{DD}$  = 26 V,  $I_{DQ}$  = 25 mA,  $P_{out}$  = 2 W PEP

f MHz	$\mathbf{Z_{source}}_{\Omega}$	$\mathbf{Z_{load}}_{\Omega}$
925	4.5 + j13.3	23.4 + j9.2
960	4.3 + j15.3	23.2 + j10.4
985	4.1 + j15.8	23.0 + j11.1

Transistor 1

 $V_{DD}$  = 26 V,  $I_{DQ}$  = 25 mA,  $P_{out}$  = 2 W PEP

f MHz	$\mathbf{Z_{source}}_{\Omega}$	$oldsymbol{Z_{load}}{\Omega}$
925	6.0 + j12.3	19.7 + j27.8
960	5.9 + j14.3	22.0 + j23.9
985	5.8 + j16.5	22.5 + j25.4

Transistor 2

 $V_{DD}$  = 26 V,  $I_{DQ}$  = 25 mA,  $P_{out}$  = 2 W PEP

f MHz	$\mathbf{Z_{source}}_{\Omega}$	$\mathbf{Z_{load}}_{\Omega}$
925	4.3 + j12.2	23.1 + j6.5
960	4.3 + j14.0	22.8 + j8.4
985	3.9 + j15.9	22.6 + j9.3

**Transistor 3** 

Z<sub>source</sub> = Test circuit impedance as measured from gate to ground.

Z<sub>load</sub> = Test circuit impedance as measured from drain to ground.

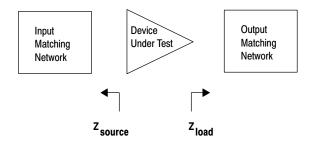


Figure 11. Series Equivalent Source and Load Impedance



## **NOTES**



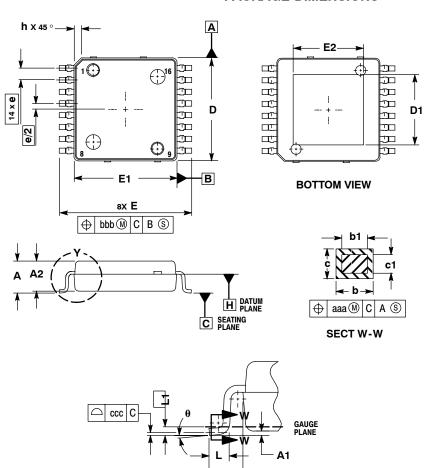
## **NOTES**



## **NOTES**



#### **PACKAGE DIMENSIONS**



**DETAIL Y** 

**CASE 978-03** ISSUE C PLASTIC **PFP-16** 

#### NOTES:

- NOTES:

  1. CONTROLLING DIMENSION: MILLIMETER.
  2. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
  3. DATUM PLANE -H- IS LOCATED AT BOTTOM OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE BOTTOM OF THE PARTING LINE.
  4. DIMENSIONS D AND E1 DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.250 PER SIDE. DIMENSIONS D AND E1 DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
  5. DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION IS 0.127 TOTAL IN EXCESS OF THE DIMENSION AT MAXIMUM MATERIAL CONDITION.
  6. DATUMS -A- AND -B- TO BE DETERMINED AT DATUMS AND -B- TO BE DETERMINED AT
- 6. DATUMS -A- AND -B- TO BE DETERMINED AT DATUM PLANE -H-.

	MILLIMETERS		
DIM	MIN	MAX	
Α	2.000	2.300	
A1	0.025	0.100	
A2	1.950	2.100	
D	6.950	7.100	
D1	4.372	5.180	
Е	8.850	9.150	
E1	6.950	7.100	
E2	4.372	5.180	
L	0.466	0.720	
L1	0.250 BSC		
b	0.300	0.432	
b1	0.300	0.375	
C	0.180	0.279	
c1	0.180	0.230	
е	0.800 BSC		
h		0.600	
θ	0°	7°	
aaa	0.200		
bbb	0.200		
ccc	0 100		



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